Search Notes

Application/Control N	ο.
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09/544,523

Examiner

Nhan T. Tran

Applicant(s)/Patent under Reexamination

LEHRMAN, MIKEL A.

Art Unit

2622

	SEARCHED				
Class	Subclass	Date	Examiner		

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Used previously cited references	5/4/2006	NT	
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